Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/546,001	HAMAOKA ET AL.	
Examiner	Art Unit	
Rita Leykin	2837	

SEARCHED					
Class	Subclass	Date	Examiner		
318	254	2/17/2006	R.L.		
	439				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
				
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
USPAT, DERWENT, EPO, JPO USPGPUB	2/17/2006	R.L.		